

Notice of References Cited

Application/Control No.

10/580,873

Applicant(s)/Patent Under
Reexamination
ARA PINILLA ET AL.

Examiner

DEVANIE DUFOUR

Art Unit

3733

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,512,448	05-1970	JEAL HARVEY PHILIP et al.	411/53
*	B	US-3,760,802	09-1973	Fischer et al.	606/63
*	C	US-3,779,239	12-1973	Fischer et al.	606/63
*	D	US-4,091,806	05-1978	Aginsky, Jacob	606/63
*	E	US-4,227,518	10-1980	Aginsky, Jacob	606/63
*	F	US-4,590,930	05-1986	Kurth et al.	606/63
*	G	US-4,858,602	08-1989	Seidel et al.	606/60
*	H	US-5,441,500	08-1995	Seidel et al.	606/67
*	I	US-5,437,674	08-1995	Worcel et al.	606/308
*	J	US-5,888,196	03-1999	Bonutti, Peter M.	600/204
*	K	US-6,355,069 B1	03-2002	DeCarlo et al.	623/23.26
*	L	US-2002/0068939 A1	06-2002	Levy et al.	606/63
*	M	US-2002/0165544 A1	11-2002	Perren et al.	606/63

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2606269 A1	05-1988	France	LAFFAY et al.	
	O	WO 2058575 A1	08-2002	World Intellect	DAVIES, JOHN BRUCE CLAYFI	
	P	SU 662082 A1	05-1979		LEVIN	
	Q	WO 9718769 A1	05-1997	World Intellect	CARRUZZO P A et al.	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/580,873

Applicant(s)/Patent Under
Reexamination
ARA PINILLA ET AL.

Examiner

DEVANIE DUFOUR

Art Unit

3733

Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY		
*	A	US-2003/0053881 A1	03-2003	Huang et al.	411/34
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number	Date	Country	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY			
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
U					
V					
W					
X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.